

<b>Notice of References Cited</b>	Application/Control No. <div style="text-align: center;"><b>09/832,677</b></div>		Applicant(s)/Patent Under Reexam <div style="text-align: center;"><b>Fowler et al.</b></div>	
	Examiner <div style="text-align: center;"><b>Rajnikant Patel</b></div>		Art Unit <div style="text-align: center;"><b>2838</b></div>	Page 1 of 1

**U.S. PATENT DOCUMENTS**

* x		Document Number <small>Country Code-Number-Kind Code</small>	Date <small>MM-YYYY<sup>1</sup></small>	Name	Classification <sup>2</sup>	
	A	6,058,032	5/2/00	Yamanaka et al.	363	71
	B	4,745,348	5/17/88	Young	318	749
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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<sup>1</sup> Dates in MM-YYYY format are publication dates.

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